

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:

Mikihiro TANAKA

Application No.:

Filed: HEREWITH

For: Wireless LAN System and
Channel Allocation Method

Examiner:

Art Unit:

**INFORMATION DISCLOSURE STATEMENT
UNDER 37 CFR §1.97 and §1.98**

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

The references cited on attached form PTO/SB/08A are being called to the attention of the Examiner. Copies of the references are enclosed. It is respectfully requested that the cited references be expressly considered during the prosecution of this application, and the references be made of record therein and appear among the "references cited" on any patent to issue therefrom.

As provided for by 37 CFR 1.97(g) and (h), no inference should be made that the information and references cited are prior art merely because they are in this statement and no representation is being made that a search has been conducted or that this statement encompasses all the possible relevant information.

Applicant believes that no fee is required for submission of this statement. However, if a fee is required, the Commissioner is authorized to deduct such fee from Deposit Account No. 20-1430. Please deduct any additional fees from, or credit any overpayment to, the above-noted Deposit Account.

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PATENT

Respectfully submitted,



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60124920 v1

Substitute for form 1449A/PTO				<i>Complete if Known</i>	
				Application Number	
				Filing Date	
				First Named Inventor	Tanaka, Mikihiro
				Art Unit	
				Examiner Name	
Sheet	1	of	1	Attorney Docket Number	16869N-104000US

U.S. PATENT DOCUMENTS+					
Examiner Initials*	Cite No. ¹	Document Number		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
		Number	Kind Code ² (if known)		
	0001	US-			
	0002	US-			
	0003	US-			
	0004	US-			
	0005	US-			
	0006	US-			
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	0016	US-			
	0017	US-			
	0018	US-			
	0019	US-			
	0020	US-			

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Foreign Patent Document		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
		Country Code ³	Number ⁴		
	0021	JP	2002-217918	08-02-2002	Hitachi Ltd
	0022	JP	06-014006	01-21-1994	Sony Corp
	0023	JP	05-219008	08-27-1993	Fujitsu Ltd
	0024				
	0025				
	0026				
	0027				
	0028				

Examiner Signature		Date Considered	
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¹EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. ¹ Applicant's unique citation designation number (optional). ² Kind Codes of U.S. Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

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